Application/Control No. Applicant(s)/Patent Under Reexamination 10/056.890 NEET, KIRK E. Notice of References Cited Examiner Art Unit Page 1 of 1 2834 Tran N. Nguyen **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-6,285,105 X 09-2001 Asao et al. 310/208 US-5,955,810 X 09-1999 Umeda et al. 310/208 X С US-6,049,154 04-2000 Asao et al. 310/201 Х D US-5,714,824 02-1998 Couture et al. 310/208 X Ε US-6,552,463 04-2003 Oohashi et al. 310/207 X F US-6,281,614 08-2001 Hill, Wolfgang 310/207 US-G US-Н US-1 j US-US-Κ L US-М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.